Form PTO 1449 (Modified)	9 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO.		SERIAL NO.			
				242873US2	10/661,650				
LIST OF	REFE	RENCES CITED BY AI	PPLICANT	APPLICANT Valabi KANAL AA A					
LIST OF REFERENCES CITED BY APPLICANT				Yoichi KANAI, et al.					
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				U.S. PATENT DOCUMENTS					
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	AO	H08-102735	04/16/1996	Japan (with English abstract)			X		
	AP	2000-298569	10/24/2000	Japan (corresponding to US Patent No 7,075,670 B1)			X		
	AQ	2002-190947	07/05/2002	Japan (corresponding to US Patent No 6,970,259 B1)	esponding to US Patent No.		X		
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	AV	2001-325249	11/22/2001	Japan (with English abstract)			X		
		OTHER R	EFERENCES (I	ncluding Author, Title, Date, Pertinen	t Pages, e	c.)			
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Examiner					Date Considered				
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